

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination IWATA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11282344 A	10-1999	Japan	ARAKAWA et al.	
	O	JP 2001140257 A	05-2001	Japan	KOBAYASHI et al.	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Chapter Four: Related Work in the Visualization of Multiple Spatial Variables"
	V	Sufer Software, "Surfer 8 - 3d contour maps and surface plots software", <a href="http://www.ssg-surfer.com/html/surfer_deails.html">http://www.ssg-surfer.com/html/surfer_deails.html</a> , 01 March 2001
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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